

Notice of References Cited

Application No.
09/453,319

Applicant(s)
Shepard

Examiner
Gail Verbitsky

Group Art Unit
2859

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U.S. PATENT DOCUMENTS

		DOCUMENT NO.	DATE	NAME	CLASS	SUBCLASS
	A	5,201,841	04.13.93	Lebeau et al.	374	5
J	B	6,000,844	12.14.99	Cramer et al.	374	5
	C	5,587,532	12.24.96	Rose	73	579
	D	4,521,118	06.04.85	Rosencwaig	374	5
	E	5,562,345	10.08.96	Heyman et al.	374	5
	F	5,406,082	04.11.95	Pearson et al.	250	339.01
	G	4,866,276	09.12.89	Leavens et al.	250	341
	H	4,803,884	02.14.89	Kaneta et al.	73	598
	I	5,407,275	04.18.95	Long	374	5
	J	3,698,234	10.17.72	Allinikov	73	15
	K	5,709,469	01.20.98	Shearer et al.	73	618
	L	4,289,030	09.15.81	Alers et al.	73	588
	M	6175416B1	01.16.01	Maris et al.	356	381

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	N	GB2164147A	03.86	GB	GB	374	4
	O	SU1081510	03.84	SU	SU	374	4
	P	JA0151046	08.84	JA	JA	374	4
	Q	SU0879452	03.86	SU	SU	374	50
	R	SU1198423	12.85	SU	SU	374	5
	S	SU0565239	07.77	SU	SU	374	5
	T	GB2168494A	06.86	GB	GB	374	5

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	U	Thermal and Infrared Methods For Nondestructive Testing of Adhesive-Bonded Structures, Kutzscher et al. July 1968	
-	V	<i>Thermal Bond Inspection System. Technical References. E. Cramer. NASA. 1993</i>	
	W	<i>Thermography and Ultrasonics Find Flaws in Composites. Langley Research Center. 09.93</i>	
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	A	4,860,687	08.29.89	Frijlink	118	500
	B	3,681,970	08.08.72	Wells	73	15.4
✓	C	5,246,291	09.21.93	Lebeau et al.	374	5
	D	4,752,140	06.21.88	Cielo et al.	374	55
	E	5,250,809	10.05.93	Nakata et al.	250	330
	F	4,589,783	05.20.86	Thomas et al.	374	45
	G	3,744,295	07.10.73	Allinikov	73	15r
✓	H	5,396,068	03.07.95	Bethea	250	330
	I	3,599,476	08.17.71	Corbett	73	15.6
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